

Search Notes

Application/Control No.

10/609,016

Examiner

/BINH K. TIEU/

Applicant(s)/Patent under
Reexamination

LE ET AL.

Art Unit

2614

SEARCHED			
Class	Subclass	Date	Examiner
455	432.1	10/7/2007	BKT
	435.1		
↓	417, 423		
370	310, 331		
↓	352, 386		
↓	401	↓	↓

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
WEST DATABASES SEARCH	10/7/2007	BKT
WEST DATABASES SEARCH	10/8/2007	BKT